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## Journal Article

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# Plasmonic Organic Hybrid Modulators – Scaling Highest-Speed Photonics to the Microscale

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**Abstract** — Complementing plasmonic slot waveguides with highly nonlinear organic materials has rendered a new generation of ultra-compact active nanophotonic components that are redefining the state-of-the-art. In this paper we review the fundamentals of this so-called plasmonic organic hybrid (POH) platform. Starting from simple phase shifters to the most compact IQ-modulators, we introduce key devices of high-speed data communications. For instance, all-plasmonic Mach-Zehnder Modulators (MZMs) are reviewed and long-term prospects are discussed. This kind of modulator already features unique properties such as a small footprint ( $<20 \mu\text{m}^2$ ), a large electro-optic bandwidth ( $>110\text{GHz}$ ), a small energy consumption ( $\sim 25 \text{fJ/bit}$ ), a large extinction ratio ( $>25 \text{dB}$ ) in combination with a record small voltage-length product of  $40 \text{V}\mu\text{m}$ . Finally, as an example for seamless integration we introduce novel plasmonic IQ-modulators. With such modulators we show the generation of advanced modulation formats (QPSK, 16 QAM) on footprints as small as  $10 \mu\text{m} \times 75 \mu\text{m}$ . This demonstration ultimately shows how plasmonics can be used to control both phase and amplitude of an optical carrier on a microscale with reasonably low losses.

**Index Terms**— Plasmonics, Plasmonic Modulators, Plasmonic Organic Hybrid, Linear Electro-optic Effect, IQ-Modulators, Mach-Zehnder Modulators

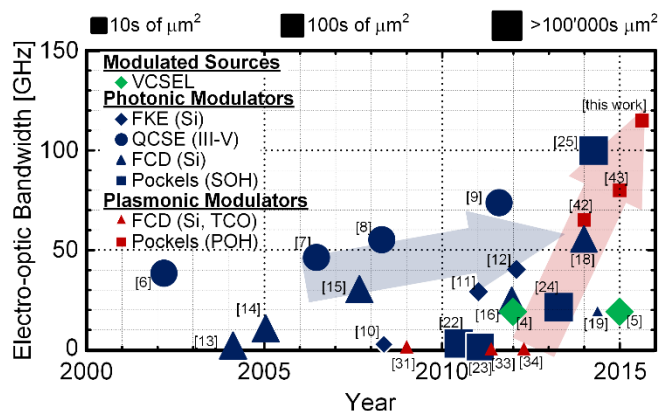
## I. INTRODUCTION

Electro-optical modulators are key elements in optical communication systems, especially in long-haul systems.

Mach-Zehnder modulators (MZMs) and nested Mach-Zehnder modulators (IQ-modulators) based on  $\text{LiNbO}_3$  have already shown encoding of advanced modulation formats such as PDM-64QAM with line rates up to 1 Tbit/s per modulator [1]. If assembled in a larger system, photonics ultimately offers Pbit/s capacity [2]. In reality such a Pbit/s system would require as many as several thousands of modulators; and while electronics are very compact, the large  $\text{cm}^2$  footprint of  $\text{LiNbO}_3$  based modulators would pose severe limitations to the overall footprint.

To present the bigger picture we have summarized the best in-class electro-optical bandwidths for various integrated optical technologies and configurations in Fig. 1. So for instance, directly modulated vertical-cavity surface-emitting lasers (VCSELs) have emerged as a viable and compact ( $>1000 \mu\text{m}^2$ ) solution for optical high-speed communications in data centers [3, 4], see  $\blacklozenge$ . Unfortunately, they generate chirped signals [5]. A more versatile solution is provided by integrated

external photonic modulators, which do not suffer from a strong chirp [5]. After a decade of development, external photonic modulators have made tremendous progress for instance in terms of electro-optic bandwidth, as indicated by the light blue arrow in Fig. 1 (please note that large symbols indicate a large footprint). These modulators encode electrical signals onto a continuous-wave (CW) optical carrier by utilizing various effects such as the quantum-confined Stark effect (QCSE -  $\bullet$ ) in III-V semiconductors [6-9], the Franz-Keldysh-effect (FKE -  $\blacklozenge$ ) in silicon-germanium (SiGe) [10-12], free-carrier dispersion (FCD -  $\blacktriangle$ ) effects in silicon [13-20] and the Pockels effect ( $\blacksquare$ ) in silicon-organic-hybrid (SOH) modulators [21-25]. Modulators based on these effects have been shown in resonant



**Fig. 1 Bandwidth and footprint of electro-optical integrated modulators** (experimental results only) – The plot shows the improvement of the bandwidth over the last 15 years for integrated photonic and plasmonic modulator as well as directly modulated VCSELs. The size of the symbol indicates the required footprint and the shape of the symbol indicates the effect it relays on. It can be seen that photonic modulators have experienced a steady but moderate increase in bandwidth over the years (blue arrow). The plot also shows how newer plasmonic modulators are about to outperform the photonic counterparts at a much smaller footprint (red arrow). The expected bandwidth is well beyond 100s of GHz.

[19, 20, 23] as well as non-resonant configurations [6-18, 21, 22, 24, 25]. Resonant disc modulators feature high Q-factors enabling compact devices with footprints of  $\approx 20 \mu\text{m}^2$ . However a high Q-factor comes at the cost of a limited electro-optical bandwidth ( $\approx 20 \text{GHz}$ ) and [19]. Alternatively, non-resonant absorption modulators based on the QCSE [6-9] or FKE [10-12] effect have demonstrated electro-optical bandwidths up to

74 GHz [9] with footprints of  $40 \mu\text{m}^2$  [11]. Yet, the capability of these devices to access multiple amplitude and phase levels in order to encode advanced modulation formats is limited. Conversely, these constraints can be overcome by MZM configurations [17, 24]. Several MZM-based devices have shown electro-optical bandwidths of 55 GHz [18] and 100 GHz [25] when utilizing the FCD in Si and the Pockels effect in SOH, respectively. However, due to a relatively weak light-matter interaction in photonic structures, these devices require rather long phase-shifters, typically  $> 500 \mu\text{m}$ , to achieve sufficient phase-shifts. As shown in Fig. 1 all modulators featuring large bandwidths are bulky devices with footprints way above several 100s of  $\mu\text{m}^2$  [9, 18, 25]. Yet, ideally, electro-optic modulators should feature a compact footprint on the order of  $\mu\text{m}^2$ , a large bandwidth ( $>100$  GHz) with the least power consumption ( $\sim\text{fJ/bit}$ ), and at the same time provide access to advanced modulation formats.

Plasmonics has been considered for some time to be a viable option for realization of compact and fast modulators [26-37]. In plasmonics, light is guided as a surface plasmon polariton (SPP) at metal-insulator interfaces [38]. This enables light confinement well below the diffraction limit resulting in an enhanced light-matter interaction [39-41]. And indeed, several research groups have reported micrometer-sized plasmonic modulators mostly exploiting the FCD effect ( $\blacktriangle$ ), see Fig. 1 [31, 33, 34]. In the future, such modulators are also expected to outperform their photonic counterparts in terms of electro-optical bandwidth. High-speed operation, however, has only recently been demonstrated by modulators relying on the plasmonic organic hybrid (POH) platform ( $\blacksquare$ ) [42, 43]. From Fig. 1, one can recognize improvements that – even though relying on a new technology – already go beyond what photonics can offer. POH modulators have experienced a rapid evolution, starting with the first proof-of-principle in 2014 60 GHz high-speed phase modulator [42], followed by the first demonstrations of an all-plasmonic MZM in 2015 [43], which has then fostered the development of a remarkably compact

plasmonic IQ-modulator [44]. Meanwhile, plasmonic modulators [45-50] have been demonstrated to operate with multilevel signals [47] to directly convert millimeter waves to the optical domain [50], to switch at the atomic scale [49] and a plasmonic interconnect solution has been suggested [48].

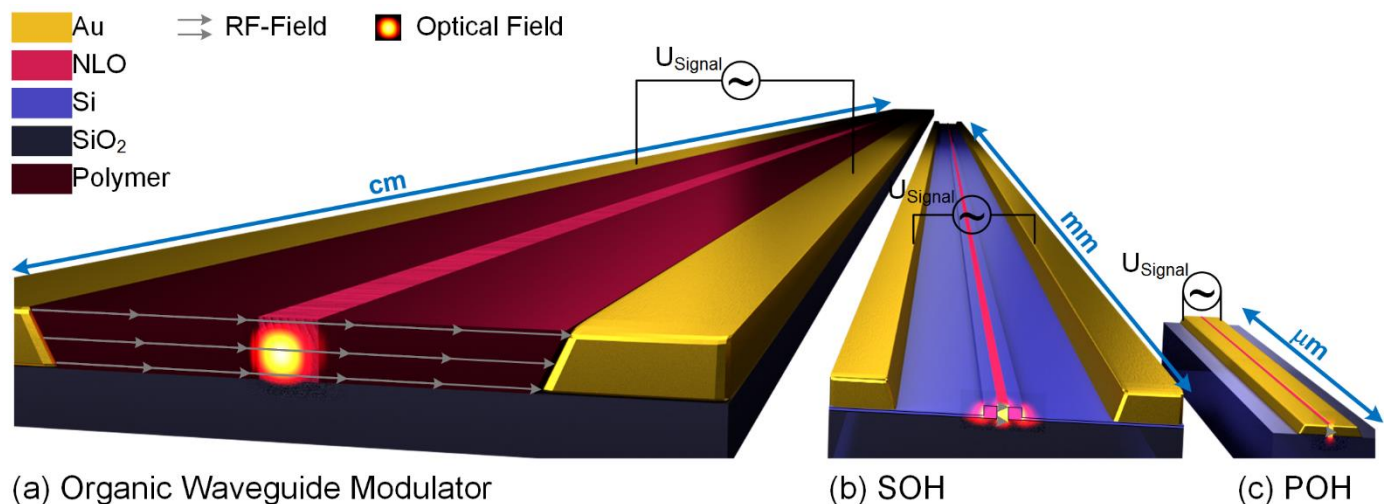
In this paper we review the plasmonic organic hybrid (POH) platform, where plasmonic waveguiding is combined with organic second-order nonlinear optical (NLO) materials to enable ultra-fast active devices. At the same time we demonstrate the potential for scaling to more complex circuits by introducing the first plasmonic IQ-modulator. To put things in context we give here the absolute numbers as obtained from the first generation of POH modulators. They feature

- Footprints of a few  $\mu\text{m}^2$
- Encoding of advanced modulation formats such as QPSK and 16 QAM enabling 144 Gbit/s
- Electro-optic bandwidths  $>110$  GHz ( $\approx\text{THz}$  expected)
- Electrical energy consumption  $\approx 25$  fJ/bit
- Voltage-length products of  $40 \text{ V}\mu\text{m}$
- Extinction ratios (ERs)  $>25$  dB
- Insertion losses (IL) of 5 dB for a single MZM

The paper is organized as follows. In section II, we review the different organic based modulator technologies such as the conventional organic waveguide modulators, the silicon organic hybrid (SOH) modulators and the plasmonic organic hybrid (POH) modulators. Section III discuss the physics behind the POH waveguide and the operating principle of the POH phase modulator. In section IV, we discuss the all-plasmonic MZM. Section V reports on the performance of the first plasmonic IQ-modulator. For more general reviews on plasmonics or on organic NLO materials in general, we recommend Refs. [51] and [52, 53], respectively.

## II. PLASMONIC ORGANIC MODULATORS: LIGHT MATTER INTERACTION BEYOND THE DIFFRACTION LIMIT

Merging NLO materials [52] with plasmonic structures [41]



**Fig. 2 Artistic view of different organic modulator technologies:** (a) Photonic organic modulator. Light (optical mode profile) is guided within a waveguide formed by the organic nonlinear optical (NLO) material, the phase is modulated by the applied drive voltage  $U_{\text{Signal}}$  and drops off over the distance of a few  $\mu\text{m}$  as indicated by the RF-field (gray). Such organic modulator devices have cm-lengths. (b) Silicon-organic hybrid (SOH) modulator have sub-millimeter lengths. Here, the electrical field drops only over the slot filled with the organic material. However, the performance is still limited as the diffraction limit forbids complete confinement of light to the slot. (c) This can be overcome by the plasmonic-organic-hybrid (POH) approach, which is not diffraction limited and enables modulator lengths of only several  $\mu\text{m}$ .

allows us to combine the advantages of each technology without suffering from the drawbacks of the respective individual technologies [42, 43]. We discuss the advantages of the POH technology over its two photonic predecessors with the help of Fig. 2. The figure depicts an artistic view of three generations of modulators that all utilize second-order NLO materials to encode an electrical signal onto an optical carrier. The three generations of modulators are (a) an organic waveguide modulator [54], (b) a photonic silicon-organic-hybrid (SOH) modulator [55] and (c) a plasmonic-organic hybrid (POH) modulator [42]. One can see that the size of the modulators decreases from centimeters (cm), to millimeters (mm), and finally to micrometers ( $\mu\text{m}$ ) when going from left to right. To understand this evolution we first discuss the NLO material system and then discuss how its properties can be used to take full advantage of the nonlinear characteristics.

Organic NLO materials with a dominant linear electro-optic effect offer some unique advantages [56].

- **Linear phase modulation:** The linear electro-optic effect (Pockels effect) [57] allows one to linearly modulate the phase of an optical signal by means of an applied electrical field. An advantage of the linear electro-optic effect is that the optical absorption of the material is hardly affected by the phase modulation.
- **Ultra-fast speed:** The linear electro-optical effect is a parametric light-matter interaction. As such, the process works on an attosecond timescale and the electro-optical bandwidth of the modulator is thus only limited by the RC-time constant of the electrodes and its associated wires [52].
- **Highest nonlinearities:** The strength of the light-matter interaction is defined by the electro-optic coefficient ( $r$ ). Current organic electro-optic (OEO) materials exhibit electric field poling-induced  $r$  coefficients up to approximately 400 pm/V [58-61], more than an order of magnitude larger than the electro-optic coefficients of  $\text{LiNbO}_3$  ( $r \approx 30$  pm/V).
- **Low energy consumption:** The energy consumption in  $\chi^{(2)}$  electro-optic modulators in an open-circuit configuration is mainly influenced by the capacitance. The capacity is proportional to the material's permittivity at radiofrequencies ( $\varepsilon_{\text{GHz}}$ ) and the dimensions of the device. Organics feature a multiple times lower permittivity compared to inorganic electro-optic materials [56], and thus allows to operate the modulator with less energy.

These characteristics of the organic NLO materials can be exploited for electro-optic modulation. In the following we will briefly discuss the three kinds of modulators:

#### A. Organic Waveguide Modulators

Organic waveguide modulators have already shown small signal sinusoidal modulation up to 150 GHz [54]. In these modulators the waveguides are formed from the NLO material, Fig. 2(a). To apply the electrical drive voltage the waveguides are embedded between two Au contact electrodes (yellow),  $U_{\text{Signal}}$ . By exploiting the Pockels effect, the refractive index of the waveguide ( $n_{\text{mat}}$ ) is linearly changed in the presence of an

electrical field

$$\Delta n_{\text{mat}} = \frac{r}{2} \cdot n_{\text{mat}}^3 \cdot E_{\text{Signal}} = \frac{r}{2} \cdot n_{\text{mat}}^3 \cdot \frac{U_{\text{Signal}}}{d_{\text{separation}}}. \quad (1)$$

Optical modes propagating in the waveguide experience a phase shift proportional to  $\Delta n_{\text{mat}}$ . In the case of a constant voltage this effect is inversely proportional to the separation distance ( $d_{\text{separation}}$ ) of the two electrodes. Thus a small gap between the electrodes would be desirable. However the minimum separation is defined by the size of the mode, which is diffraction limited to a large mode because of the small refractive index difference between the guiding organic materials ( $n_{\text{mat}} \approx 1.6-1.8$ ) and the cladding/substrate materials ( $n_{\text{SiO}_2} \approx 1.44$ ). This results in an electrode spacing of several  $\mu\text{m}$ , which due to the weak light-matter interaction leads to modulator lengths of centimeters [54]. For the sake of completeness, it should be mentioned here that typical implementations of the organic modulator would be along the vertical axis. However, to emphasize the evolution of the modulators and their operating principle, we have drawn the organic modulator in a lateral arrangement of the electrodes with the waveguide.

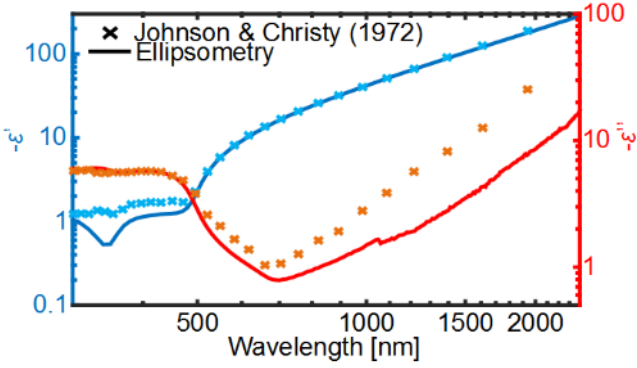
#### B. Silicon-Organic-Hybrid Modulators

A more efficient approach to exploit the Pockels effect on the silicon platform is the silicon-organic hybrid (SOH) technology [55]. As shown in Fig. 2(b), conductive silicon (blue) is used to form two Si rails separated by a narrow slot, which is filled with the NLO material. The advantage of this approach is that the voltage drops off across the narrow slot of  $\sim 150-200$  nm width. This way, the electrical field has its maximum in the narrow NLO slot. As the electrical field is much higher than in the organic waveguide modulator the length of the modulator can be reduced to millimeters and submillimeters. Nevertheless, this configuration suffers from two main drawbacks. First, silicon as a semiconductor has a higher resistance than metals leading to a limited RC response [62]. Second, the optical mode is only partially confined to the NLO material so that only part of the optical mode and the electrical field interact (the field interaction factor is in the order of 0.25 [55]). The limited interaction then strongly reduces the efficiency of the phase modulator.

#### C. Plasmonic-Organic-Hybrid Modulators

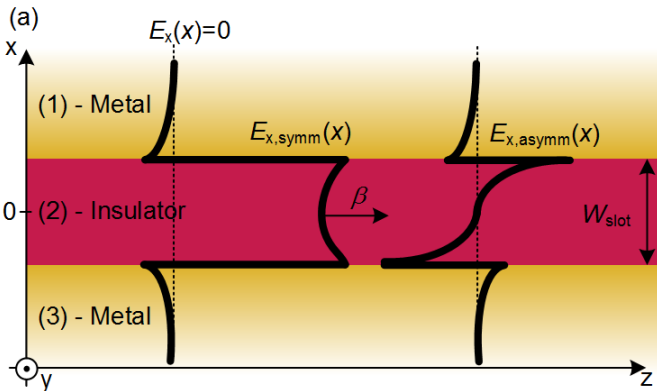
In contrast to the previous two approaches, POH modulators use the Au contact electrodes to directly form a metal-insulator-metal (MIM) slot waveguide, see Fig. 2(c). At the gold-NLO interfaces light is guided as surface plasmon polaritons (SPPs). This approach combines the many advantages offered by organic nonlinear optical materials with plasmonic slot waveguides, and allows one to mitigate the deficiencies of the previous technologies by taking advantage of plasmonics, namely:

- **Sub-diffraction confinement of light:** Plasmonics offers light confinement in metal-insulator-metal waveguides well below the diffraction limit. SPPs are particularly well confined to the metal-insulator surface for low refractive index materials such as organic NLO materials[39, 41].



**Fig. 3 Real and imaginary permittivity values of Au:** Progress in fabrication has led to a reduction of plasmonic losses in noble metals by as much as a factor 2. The real ( $\epsilon'$ ) and imaginary ( $\epsilon''$ ) parts of the permittivity are plotted as a function of the wavelength. The curves show the newly measured values (—solid lines) and the crosses (x) show the standard values as reported in Ref. [66], Image adapted from Ref. [43].

- **Enhanced light-matter interaction:** The achievable voltage-length product in plasmonics is one order of magnitude smaller compared to photonics. This can be traced back to an increased field energy interaction factor and a large slow down factor. The enhanced light-matter interaction is discussed in detail in section III.
- **Small RC time constants:** Highly conductive metals are used to guide light and electrical signals simultaneously, i.e.,  $R \rightarrow 0$ . In addition, taking advantage of the enhanced light-matter interaction devices are very short such that potential capacitances between the metals are sufficiently small, resulting altogether in sub-picosecond RC-time constants ( $\tau_{RC} < \text{ps}$ ).
- **Reduced Plasmonic Losses:** Recent measurements of the optical properties of gold thin films [63–65] revealed that plasmonic losses of noble metals are lower compared to previously reported values by Johnson & Christy [66], see Fig. 3. In addition, since the length of plasmonic devices is typically in the  $\mu\text{m}$ -range, the total loss through the device is relatively low.



Thus, plasmonics provides a viable solution to overcome the drawbacks of purely organic or SOH approaches as light can be confined within low refractive index materials on the nm-scale by utilizing MIM waveguides.

### III. PLASMONIC ORGANIC HYBRID WAVEGUIDES

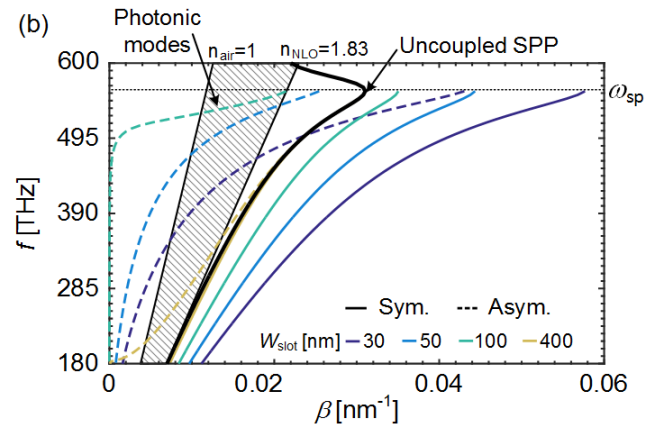
This section starts with the optical properties of passive plasmonic slot waveguides before discussing their active electro-optic implementation in a POH phase modulator.

#### A. Passive Metal-Insulator-Metal (MIM) Waveguide

The longitudinal cross section of a passive MIM waveguide is depicted in Fig. 4(a). The waveguide is defined by two gold layers separated by  $w_{\text{slot}}$  and a layer of insulating nonlinear material in-between. SPPs propagate parallel to the metal-insulator interfaces as indicated by the direction of the wave vector  $\beta$ . Equivalent to photonics, SPPs can be described as plasmonic modes which are only TM polarized (only  $E_x$ ,  $E_z$  and  $H_y$  are unequal to zero) [67]. Following Ref. [41] we will discuss the properties of these modes where the MIM stack is assumed to be homogenous along  $y$ . Starting from the Helmholtz equation, the TM-field distribution within each layer  $m$  can be described by

$$\begin{aligned}
 H_{y,m}(x, z) &= \left( A_m e^{k_{x,m} \cdot x} + B_m e^{-k_{x,m} \cdot x} \right) e^{j\gamma z} \\
 E_{z,m}(x, z) &= \left( -j \frac{k_{x,m}}{\omega \epsilon_0 \epsilon_m} A_m e^{k_{x,m} \cdot x} + j \frac{k_{x,m}}{\omega \epsilon_0 \epsilon_m} B_m e^{-k_{x,m} \cdot x} \right) e^{j\gamma z} \\
 E_{x,m}(x, z) &= \left( \frac{\gamma}{\omega \epsilon_0 \epsilon_m} A_m e^{k_{x,m} \cdot x} + \frac{\gamma}{\omega \epsilon_0 \epsilon_m} B_m e^{-k_{x,m} \cdot x} \right) e^{j\gamma z}
 \end{aligned} \tag{2}$$

where  $\gamma$  is the complex propagation constant. Its real part  $\beta$  describes the phase propagation while its imaginary part  $\alpha$  models the absorption. The transverse wave vector  $k_{x,m}$  is related to  $\gamma$  by  $k_m^2 = \gamma^2 - k_0^2 \epsilon_m(\omega)$ . The relative permittivity of



**Fig. 4 Properties of plasmonic modes:** (a) MIM-stack homogenous along  $y$  direction. Red indicates the insulating organic NLO material while yellow represents Au. The  $E_x$  field of the fundamental symmetric plasmonic mode is drawn in black. The field in the dielectric is quite enhanced over the field in the metal due to the large mismatch between NLO's and metals' permittivity. (b) Dispersion relation  $\beta(\omega)$  for frequencies ranging from 180 THz to 600 THz for the symmetric (solid line) and asymmetric (dashed) plasmonic modes at different slot widths. In the same plot we also give the dispersion relation of an uncoupled SPP as it would exist at a single MI interface. The gray area highlights all possible wave vectors of a hypothetical ideal photonic waveguide with an air-cladding and the nonlinear optical material as a guiding layer. Plasmonic modes are guided when their propagation constants  $\beta$  is larger than the NLO's light line. These modes are confined to the nearfield and cannot couple to photonic modes. The symmetric mode exists for all frequencies and widths while the asymmetric mode is cut-off for small frequencies and widths.



the metal (M) and insulator (I) is given by  $\epsilon_M$  and  $\epsilon_I$ , respectively. The angular frequency is  $\omega$ .  $A_m$  and  $B_m$  are constants associated with the respective layer  $m$ . Guided modes require that energy is confined to the core, meaning the field intensity must be zero for  $x \rightarrow \pm\infty$ . This requires  $A_1$  and  $B_3$  to be zero as  $k_x$  is larger than zero. Solving Eq (2) for the tangential boundary conditions leads to the mode's dispersion relation  $\beta(\omega)$ , which is defined by the implicit equation

$$e^{-2k_1 w} = 2 \frac{k_1/\epsilon_1(\omega) + k_M/\epsilon_M(\omega)}{k_1/\epsilon_1(\omega) - k_M/\epsilon_M(\omega)}. \quad (3)$$

Two orthogonal plasmonic solutions can be found for the slot waveguide, Fig. 4 (a). One has a symmetric  $E_x$  component while the other one has an asymmetric  $E_x$  component with respect to the center of the waveguide. When increasing the slot width, the left hand side of equation (3) becomes zero and the right hand side can be rearranged to the following equation when substituting  $k_m^2 = \gamma^2 - k_0^2 \epsilon_m(\omega)$

$$\gamma(\omega) = \beta_0(\omega) \sqrt{\frac{\epsilon_M(\omega)\epsilon_I(\omega)}{\epsilon_M(\omega) + \epsilon_I(\omega)}}. \quad (4)$$

This is the solution for a single metal-insulator interface. In the case of a large slot width both modes converge towards the solution of single uncoupled SPPs.

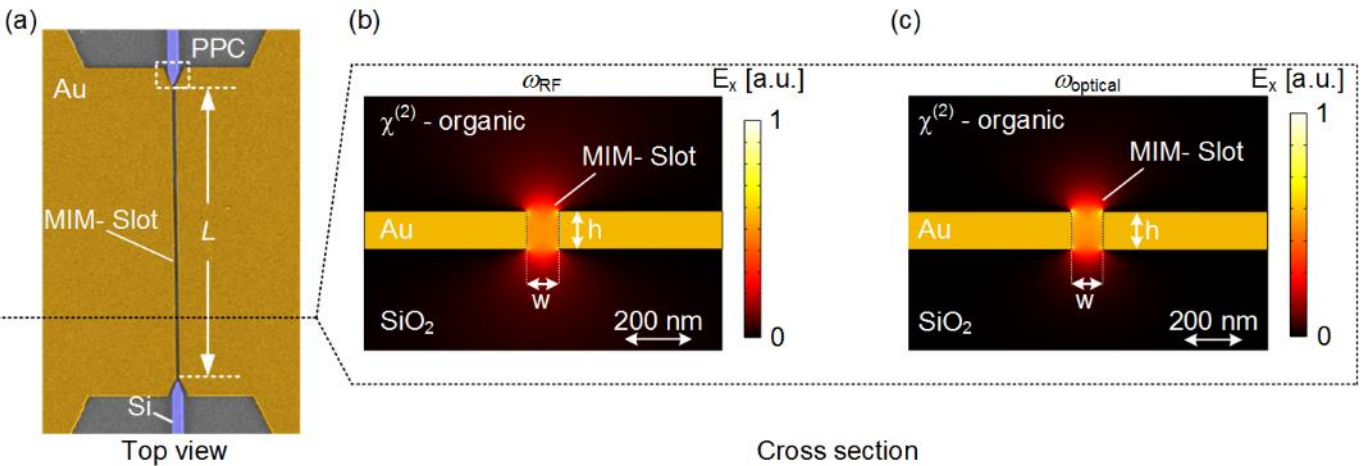
Fig. 4(b) shows the frequency  $f$  ranging from 180 to 600 THz as a function of the propagation constant's real part  $\beta$ . The graph compares plasmonic symmetric (solid) and asymmetric (dashed) modes, the plasmonic mode of a single interface (black) and all wave vectors which can exist in a photonic NLO waveguide (grey hatched area). The figure shows only symmetric and asymmetric bound modes below the plasmon frequency  $\omega_{SP}$ . It can be seen that the wave vector below the plasmon frequency, of the uncoupled SPP mode is always larger than the wave vector of the organic NLO light line ( $n_{NLO} = 1.83$ ). Thus, once launched as a SPP, light cannot couple back to the photonic modes as it is confined to the interface. In the case of the coupled symmetric plasmonic mode

the wave vector  $\beta$  is larger for reduced slot widths, resulting from a stronger confinement to the near field, see equation (2). In contrast, the asymmetric modes are in the cut-off and guided modes exist only in the limit of large widths or high frequencies. Thus, plasmonic modulators with a narrow slot only guide the fundamental plasmonic modes. This mode shows a significant light confinement in combination with an enhanced transverse electrical field and a strong nonlinear dispersion relation.

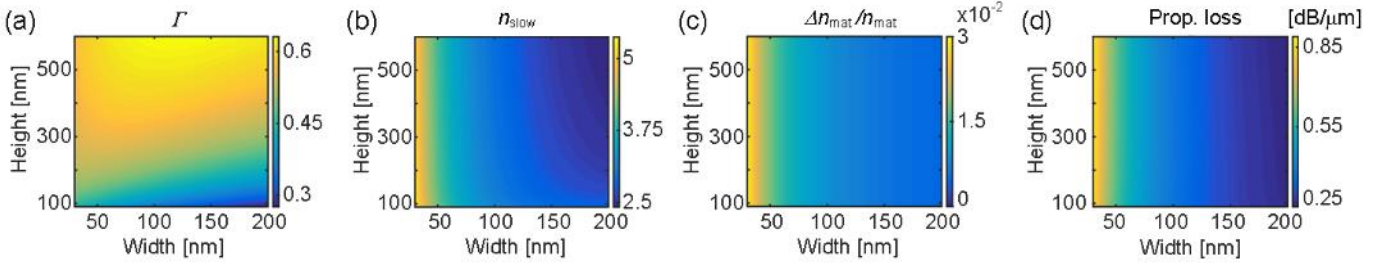
### B. Plasmonic Organic Hybrid Phase Modulator

Fig. 5(a) shows a colorized SEM image of a typical plasmonic-organic-hybrid phase modulator (PPM) realized on an SOI substrate. Gold (Au) contact pads are used simultaneously to form the 150 nm high MIM (Au/NLO/Au) slot waveguide and to apply the electrical signal to the slot via highly conductive metallic contacts. The slot is filled with an organic second-order NLO material and the Pockels effect can be exploited to encode the electrical signal onto the optical carrier. Light is coupled to and from the MIM-slot by silicon waveguides via photonic-plasmonic converters (PPC) [68], which gradually convert the photonic mode into a plasmonic mode by tapering down the Si waveguides and tapering up the contact pads. The SPP then propagates along the slot. When a voltage is applied across the slot, the refractive index of the electro-optic organic material is changed and a phase shift is induced onto the SPP. The accumulated phase shift ( $\Delta\phi$ ) after a propagation length  $L$  is given by [43],

$$\begin{aligned} \Delta\phi(L, E_{\text{sig}}) &= \Delta\beta \cdot L = \frac{2\pi}{\lambda_0} \cdot \Delta n_{\text{eff}}(E_{\text{sig}}) \cdot L \\ &= \frac{2\pi}{\lambda_0} \cdot \Gamma \cdot n_{\text{slow}} \cdot \frac{\Delta n_{\text{mat}}(E_{\text{sig}})}{n_{\text{mat}}} \cdot L \end{aligned} \quad (5)$$



**Fig. 5 Plasmonic phase modulator:** (a) shows a colorized SEM image of the phase modulator. Au is indicated in yellow, silicon in blue and SiO<sub>2</sub> is given in gray. The two Au contact pads form the MIM slot waveguide, which is filled with the organic material. Light is coupled to and from the slot by Plasmonic-Photonic couplers (PPCs). The cross section with the RF and optical fields are shown in (b) and (c) for a slot with height ( $h$ ) and slot width ( $w$ ) of 150 nm and 100 nm, respectively. Both images show the simulated  $E_x$  component at optical and RF-frequency, respectively. Their perfect overlap suggests the strongest possible light-matter interaction.



**Fig. 6 Contributions to the enhanced light-matter interaction:** The figures show the dependency of the three major terms that contribute to the overall refractive index change in a plasmonic modulator as a function of the slot width and slot height. In all plots the applied voltage across the slot has been kept constant. (a) Field energy interaction factor: It is proportional to the overlap integral between RF and optical field. (b) Slow down factor and (c) dependency of the relative change of the refractive index: It varies inversely with the width of the slot. (d) Plasmonic propagation losses as a function of the slot geometry.

The phase shift depends on the change of the effective refractive index  $\Delta n_{\text{eff}}$  of the plasmonic mode'. Its strength depends on three factors. Namely, the field energy interaction factor ( $\Gamma$ ), the slow down factor of the SPP ( $n_{\text{slow}}$ ) and the electric field induced relative change of the material's refractive index ( $\Delta n_{\text{mat}}/n_{\text{mat}}$ ). In the following we will briefly discuss these three dominant factors and the plasmonic propagation losses as a function of the waveguide geometry (height and width), Fig. 6(a)-(d). For more details as well as for a comparison with the SOH approach we refer the reader to Ref. [43].

The field energy interaction factor  $\Gamma$  is given by the overlap between the field profile at optical frequencies and the RF frequencies. Only the  $E_x$  component of the field in the slot's active region ( $w_{\text{slot}} \cdot h_{\text{slot}}$ ) is contributing to the light matter interaction [43]. The simulated RF and optical fields are shown in Fig. 5(b) and Fig. 5(c), respectively, for a slot width  $w$  of 100 nm and a height  $h$  of 150 nm. While both fields are mostly confined to the slot, the fields are leaking out in vertical direction thereby reducing  $\Gamma$ . Fig. 6(a) shows  $\Gamma$  as a function of slot width and height. Smaller width or larger height results in an enhanced field energy interaction factor as the leakage of the optical field in the vertical direction decreases. Upon a further decrease of the width,  $w$ , below 30 nm the field energy interaction factor will decrease as the field penetrates into the metal.

The slow-down factor ( $n_{\text{slow}}$ ) of the SPPs originates from the field penetration into the metal. This can be understood by the fact that the fraction of the electric field in the metal has an  $E_x$  field in the opposite direction, see Fig. 6(a). The direction of the  $H_y$  field is the same in the metal and the insulator, see equation (2). As a consequence, the fraction of the mode in the metal has a Poynting vector showing in the backward direction. Thus, the SPP is on average slowed down when the field penetrates more into the metal. The quantitative results for  $n_{\text{slow}}$  are shown in Fig. 6(b) as a function of  $w$  and  $h$ . For smaller widths the increase of the slow-down factor shows that the penetration of the field into the metal is increasing with narrower slots ( $n_{\text{slow}} = 2.6$  at 200 nm and up to 4.9 at 30 nm). Alternatively, the slow-down factor can be approximated by the slope of the dispersion relation – flat regions correspond to slower light, see Fig. 4(b).

Fig. 6(c) shows the change of the relative refractive index  $\Delta n_{\text{mat}}/n_{\text{mat}}$  as a function of  $w$  and  $h$  for a constant voltage (10 V). The  $1/w_{\text{slot}}$  dependency of  $\Delta n_{\text{mat}}/n_{\text{mat}}$  is due to the fact that the

applied voltage drops completely across the nm-scaled MIM slot, see Fig. 5(b). This narrow slot is actually one of the reasons that the electrical fields are several orders of magnitude larger compared to organic waveguide modulators where the voltage drops over several microns.

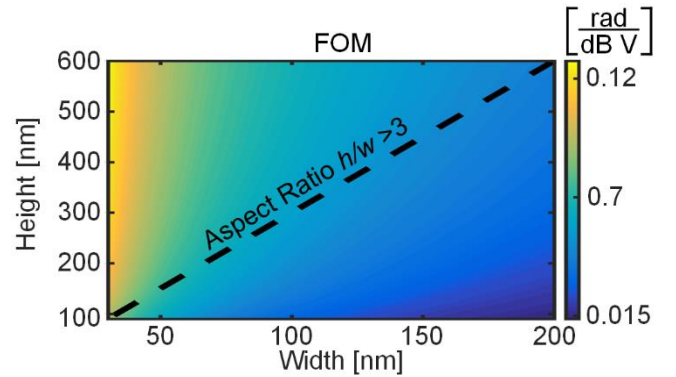
The dependency of plasmonic propagation losses on the waveguide geometry is given in Fig. 6(d). The losses are highest for smallest  $w$ , as the field penetration into the metal is largest.

The enhanced light-matter interaction provided by the MIM-slot waveguides comes at the expense of increased propagation losses  $\approx \text{dB}/\mu\text{m}$ . Yet, the enhancement of the light-matter interaction pays off with a reduced device length and results in lowest device losses for smallest slot widths.

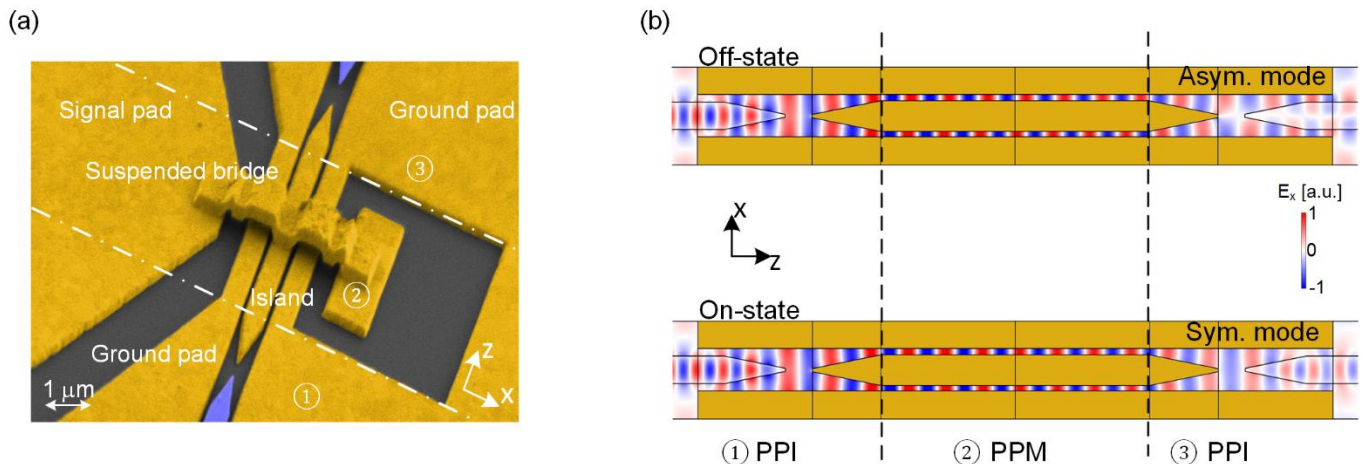
To evaluate the performance of PPMs we use a figure-of-merit (FOM) relating phase modulation per voltage and losses

$$\text{FOM} = \frac{\Delta\phi}{\text{Propagation losses}_{\text{dB}} \cdot U_{\text{sig}}} \left[ \frac{\text{rad} \cdot \mu\text{m}}{\mu\text{m} \cdot \text{dB}} \cdot \frac{1}{\text{V}} \right] \quad (6)$$

Here  $\Delta\phi$  is the accumulated phase change in rad after a SPP has propagated  $1 \mu\text{m}$  divided by the propagation losses and an applied voltage  $U_{\text{signal}}$ . Fig. 7 shows the simulated FOM as a function of the slot width and height for an electro-optic coefficient  $r_{33} = 180 \text{ pm/V}$ . The dashed line indicates the limits of our fabrication technology in terms of height to width aspect ratios. In our process, aspect ratios of up to 3:1 can be fabricated



**Fig. 7 Figure-of-Merit:** The plot shows the achievable FOM as a function of the slot's height and width. The FOM shows how much phase shift can be accumulated per 1 dB propagation loss and 1 V applied voltage. The dashed line indicates an aspect ratio ( $h/w$ ) of 3. This line marks the current fabrication limits. Aspect ratios above 3 – even though more promising – are difficult to fabricate.



**Fig. 8 The all-plasmonic MZM:** (a) Colorized SEM image of the modulator. The plasmonic interferometer is formed by the metallic island and the metallic contact pads. An electrical signal can be applied to the island via a suspended bridge. Light is coupled to and from the interferometer by plasmonic-photonic interferometers (PPI). (b) FEM-simulations showing the plasmonic modes in the “off-” and “on-state”. In the off-state the fields are out of phase at the output, while they are in phase in the on-state. Light is coupled to guided modes of the silicon waveguide only when the modulator is in the “on-state”. Image adapted from Ref. [43].

reliably resulting in a maximum FOM of 0.095 for a slot width of 30 nm and height of 90 nm. A 4 μm long MZM with such PPMs would require a voltages of  $\approx 4.5$  V to switch from on to off while having insertion losses of  $\approx 4$  dB leading to  $U_{\pi}L$  below 20 Vμm. Additionally, introducing most recent organic NLO materials with higher nonlinearities [58-61] would reduce the voltage length product below 10Vμm and sub-fJ/bit energy consumptions could be reached.

In our own experiments, we measured record voltage-length products down to 40 Vμm for a 6μm long MZM with slot widths of 30nm. The discrepancy to the theory is attributed to the not yet optimized poling procedures and tilted sidewalls, which degrade the efficiency quite a bit for such narrow slots.

#### IV. INTEGRATED ALL-PLASMONIC MACH-ZEHNDER MODULATOR

Integrating two phase modulators into a plasmonic interferometer configuration allows one to fabricate Mach-Zehnder modulators, which are orders of magnitude smaller than any other MZM. Despite the exceptionally compact solution with a footprint of a few microns squared only efficient amplitude modulation up to highest speed is found. The operation principle, design guidelines, performance characteristics and experimental results are discussed in the following sections by partially referring to results reported in Ref. [43] and by introducing more recent results.

##### A. Operating Principle

An all-plasmonic MZM (device A - Table 1) is shown in Fig. 8 (a). The colorized SEM picture shows the so-called “Island” structure with suspended bridges that connect the “Island” to the neighboring signal pad. The signal pad is used to contact the modulator using standard RF probes. Compared to other approaches [47] the island is a significantly narrowed signal electrode that allows the amplitude modulation to take place within the dimensions of a silicon photonic single mode waveguide. Silicon waveguides were used to feed CW light to

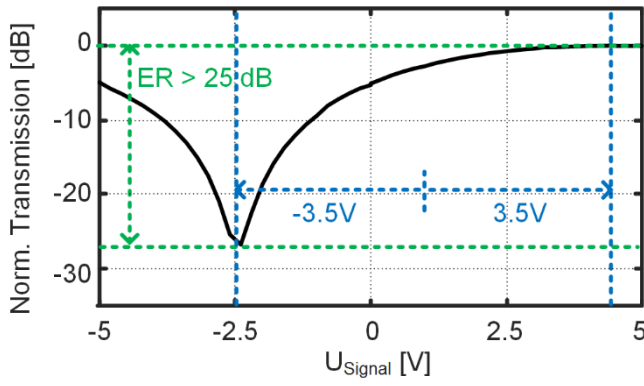
the modulator and extract the modulated optical signal. To convert light from photonic into plasmonic modes photonic plasmonic interference (PPI) sections are used at the input and output of the modulator section.

The operating scheme of the all-plasmonic MZM can be understood with the help of Fig. 8(b), showing the simulated  $E_x$  component in the off - and on-state of the modulator. Light guided in the input silicon waveguide ( $TE_{00}$ ) is coupled to a symmetric plasmonic mode by tapering down the silicon waveguide. This symmetric plasmonic mode equally excites two in-phase SPP in the upper and lower MIM slot waveguides. The two MIM waveguides are filled with a second-order nonlinear optical material (DLD164) [61] and represent the phase modulators of the device. The relative phase of the SPPs at the output of the phase shifters is actively controlled by a voltage ( $U_{\text{Signal}}$ ) applied between the “Island” and the outer ground electrodes. In the off-state the voltage is chosen such that the phase difference between both arms is  $\pi$  and an asymmetric plasmonic mode is excited at the output tip of the island. On the other hand, in the on-state the SPPs of the two PPM are in phase and a symmetric plasmonic modes is excited at the outlet. The latter couples to a guided photonic mode ( $TE_{00}$ ) of the silicon waveguide while the former is mainly coupled to lossy evanescent modes. Thus, the phase modulation is translated into an amplitude modulation.

##### B. Transfer Function of an All-Plasmonic MZM

The measured voltage dependent intensity transfer function of device B (all-plasmonic MZM) is depicted in Fig. 10. This device features slot widths of  $\sim 40$  nm and a length of 6μm. Narrowing down the slot widths has been made possible by reducing the gold height from 200 nm (device A) to 150 nm. The applied DC voltage was swept from  $-5$  V to  $+5$  V while the transmitted optical power was measured. The measured power was normalized to the power in the on-state. The device is switched from the on- to the off-state by a voltage of  $U_{\pi} \approx 7$  V. Considering the μm-length of the device a record low voltage-length product of  $\approx 40$  Vμm was achieved. Furthermore, the





**Fig. 10 MZM transfer function:** Normalized transmission plotted as a function of the drive voltage ( $U_{\text{signal}}$ ) for phase shifters of  $6 \mu\text{m}$  length. The measurement reveals record low voltage-length product of  $40 \text{ V}\mu\text{m}$ . The large Extinction ratio confirms that the small-footprint enables symmetric interferometers.

measured extinction ratio (ER) between on- and off-state is 26 dB which is significantly larger than the value reported in Ref. [43].

The transfer function of the all-plasmonic modulator can be modeled by using transfer matrices adapted from Ref. [47]

$$\begin{bmatrix} E_{\text{TE}_{00},\text{out}} \end{bmatrix} = T_{\text{MZM}} \cdot \begin{bmatrix} E_{\text{TE}_{00},\text{in}} \end{bmatrix}, \quad (7)$$

$$\text{with } T_{\text{MZM}} = T_{\text{PPI},\text{out}} \cdot T_{\text{PPM}} \cdot T_{\text{PPI},\text{in}}. \quad (8)$$

The incident photonic  $\text{TE}_{00}$  mode ( $E_{\text{TE}_{00},\text{in}}$ ) is mapped onto the output  $\text{TE}_{00}$  photonic mode ( $E_{\text{TE}_{00},\text{out}}$ ) of the silicon waveguide by the MZM's transfer matrix ( $T_{\text{MZM}}$ ). The contributions of the individual components, such as PPIs and PPM, are given by their individual transfer matrices  $T_{\text{PPI}}$  and  $T_{\text{PPM}}$ , respectively.

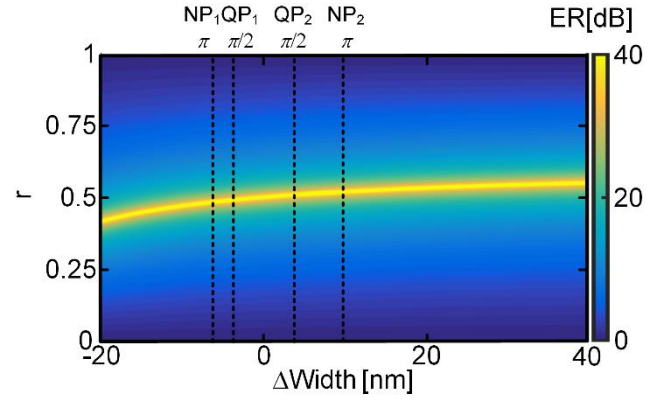
$$T_{\text{PPI},\text{out}} = \sqrt{c_{\text{PPI},\text{out}}} \cdot \begin{bmatrix} \sqrt{r} & \sqrt{1-r} \end{bmatrix}, \quad (9)$$

$$T_{\text{PPM}} = \begin{bmatrix} e^{-j(\beta_1 + \Delta\beta_1(U_{\text{sig}}))L - \frac{\alpha_1}{2}L} & 0 \\ 0 & e^{-j(\beta_2 + \Delta\beta_2(U_{\text{sig}}))L - \frac{\alpha_2}{2}L} \end{bmatrix} \quad (10)$$

$$T_{\text{PPI},\text{in}} = \sqrt{c_{\text{PPI},\text{in}}} \cdot \begin{bmatrix} \sqrt{r} \\ \sqrt{1-r} \end{bmatrix} \quad (11)$$

The coupling efficiency of the photonic-plasmonic interference (PPI) section is given by  $c_{\text{PPI}}$  while  $r$  represents the splitting ratio of the PPI coupler. A value of  $r = 0.5$  indicates an equal splitting and combining of energy entering the PPM and leaving the PPM, respectively.  $T_{\text{PPM}}$  describes the evolution of the phase and amplitude along the two arms of the interferometer. The SPPs' propagation constant  $\beta_i(w_i)$  as well as the SPPs' power attenuation  $\alpha_i(w_i)$  depends on the geometry  $w_i$  of the waveguide. The modulation of the optical carrier by an applied electrical signal is described by  $\Delta\beta_i(w_i, U_{\text{sig}})$ , which is a function of the applied voltage ( $U_{\text{signal}}$ ) and slot width ( $w_i$ ), see Eq. (5) section II.

Data transmissions based on direct detection or coherent detection requires that the MZM is operated in the quadrature point (QP) or the Null point (NP - off state), respectively. To operate this device in the respective operation point a phase-

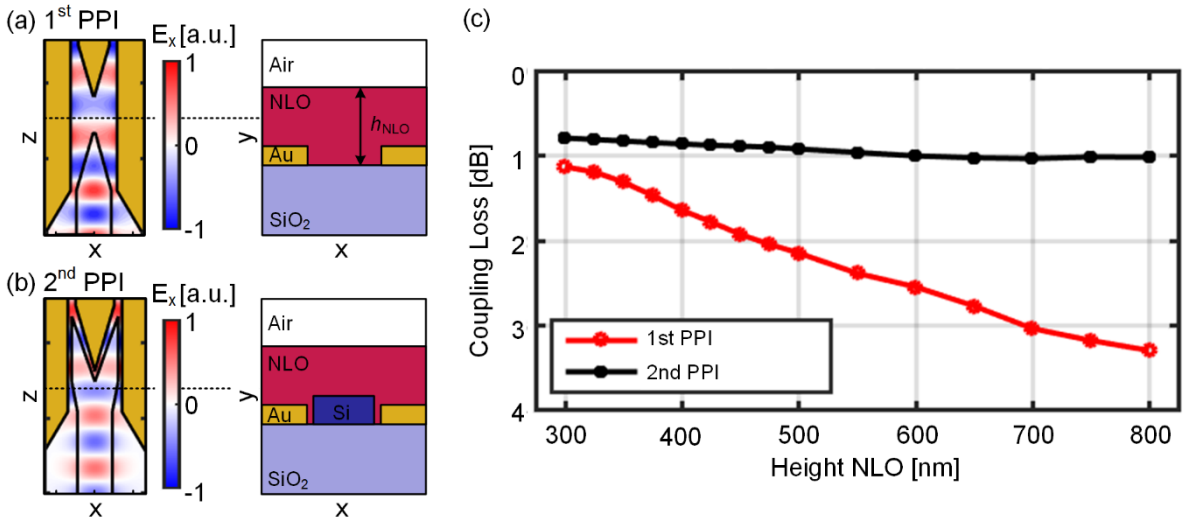


**Fig. 9 Extinction Ratio** as a function of the splitting ratio  $r$  and a slot asymmetry. The dashed lines indicate slot width differences resulting in a phase difference between the two Mach-Zehnder arms in the amount of  $\pi$  and  $\pi/2$ . This phase differences correspond to operations in the null point (NP) and quadrature point (QP), respectively. The inherent reduction of the ER for unequal slot widths in these operation points is uncritical since the ER remains high in all cases. Only for large slot width differences the splitting ratio  $r$  has to be adapted to maintain high ERs.

offset in the two arms needs to be adapted to either  $\pi/2$  for the QP or  $\pi$  for the NP operation. This can be achieved by either applying a voltage at the expense of higher electrical fields in the slots or by introducing asymmetric slot widths  $w_1$  and  $w_2$  in the phase shifter arms. [43]. The latter approach also comes with an absorption  $\Delta\alpha = \alpha_1 - \alpha_2$  change and thus influences the extinction ratio (ER) [47]. The general expression for the extinction ratio can be obtained by dividing the transfer function (7) for a signal in the on and off-state. When uneven splitting ratios (11) are used in (7), then the ER can be derived as a function of the power splitting ratio  $r$  and slot width difference  $\Delta w = w_1 - w_2$

$$\begin{aligned} ER(\Delta w, r) &= \left| \frac{E_{\text{on}}}{E_{\text{off}}} \right|^2 = \left| \frac{r e^{-\frac{\alpha_1(w_1)L}{2}} - (1-r) e^{-\frac{\alpha_2(w_2)L}{2}}}{r e^{-\frac{\alpha_1(w_1)L}{2}} + (1-r) e^{-\frac{\alpha_2(w_2)L}{2}}} \right|^2 \\ &= \left| \frac{\left( e^{-\frac{\Delta\alpha(\Delta w)L}{2}} + 1 \right) r - 1}{\left( e^{-\frac{\Delta\alpha(\Delta w)L}{2}} - 1 \right) r + 1} \right|^2. \quad (12) \end{aligned}$$

The ER in Eq. (12) has been plotted in Fig. 9 as a function of slot width variations  $\Delta w$ , and a variation in the splitting ratio  $r$  for device B with a slot width of  $40 \text{ nm}$ , a gold height of  $150 \text{ nm}$  and a device length of  $6 \mu\text{m}$ . Since varying slot widths also results in phase-offsets, we have indicated the respective phase offsets that correspond to a particular  $\Delta w$  by dashed lines. The yellow colors indicate that the ER remains high even when varying  $\Delta w$ . Furthermore, highest ERs can be achieved by adjusting the splitting ratio  $r$  and coupling more power to and from the MZI arm with higher propagation losses. It should be noted that a variation to a narrower slot in one arm increases the insertion loss of the device, while a variation to a wider slot increases the  $\pi$ -voltage  $U_\pi$  of the modulator [47]. Fabrication deviations can lead to a slight shift of the operation point, which can be adjusted by a small bias.



**Fig. 11 Coupling schemas for conversion of light from a silicon waveguide to a slot SPP:** (a) Shows the geometry of the coupler used in the initial proof of principle demonstration [43], while (b) shows the geometry of the improved coupling scheme as introduced in this and more recently in Ref. [44]. The blue/red fields show simulated field distributions. (c) Coupling losses as a function of the cladding height. The coupling efficiency of the old design in (a) strongly varies with the cladding height, while the new scheme from (b) is almost independent of the cladding height with coupling losses below 1 dB.

### C. Losses

Of particular interest are the minimum inherent losses that go along with a plasmonic modulator. Using a new design, simulations indicated that total chip losses of a device can be as small as 4.5 dB. This would correspond to a loss reduction by 3.5 dB compared to the experimental losses reported for device A in Ref. [43]. The improvement results from an optimized photonic-plasmonic converter/splitter (PPI) structure. We will now discuss the losses in more detail.

Using Eq. (7) the losses for a symmetric MZM ( $r=0.5$  and  $\alpha_1 = \alpha_2 = \alpha$ ) are

$$\begin{aligned}
 IL &= \left| \frac{E_{\text{on}}}{E_{\text{in}}} \right|^2 = c_{\text{PPI}}^2 \cdot \left| r \cdot e^{-\frac{\alpha_1 L}{2}} + (1-r) \cdot e^{-\frac{\alpha_2 L}{2}} \right|^2, \\
 &= c_{\text{PPI}}^2 e^{-\frac{\alpha L}{2}},
 \end{aligned} \quad (13)$$

where  $c_{\text{PPI}}$  accounts for the losses of the photonic-to-plasmonic converter and  $\exp(\alpha/2 \cdot l)$  models the plasmonic propagation losses in the phase modulators.

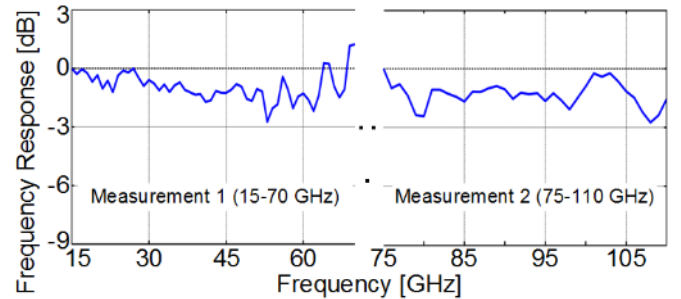
With our first generation of PPI couplers we found coupling losses of  $c_{\text{PPI}}=2.75$  dB per coupler [43]. The first generation geometry is shown in Fig. 11(a). The left image shows a top view with the simulated field profile while the right image depicts the structure at the position of the dashed line. Our analysis shows that the coupling efficiency for this geometry is strongly influenced by the height of the NLO cladding ( $h_{\text{NLO}}$ ). The dependency of the coupling efficiency (red line) on the height of the NLO material is plotted in Fig. 11(c). Reducing the height enables coupling losses down to 1.1 dB while coupling losses on the order of 3 dB are found for NLO heights of 600-800 nm such as used in Ref. [43]. The large coupling losses are caused by radiative cladding modes in the NLO material, which are excited when light is coupled from the Si waveguide to SPPs in the broad MIM waveguide (Fig. 11(a) dashed line). The radiative modes exist for large heights of the NLO material while they are cut-off for small heights.

Alternatively, the coupling efficiency can be improved by guiding light within Si rails up to the narrow phase shifter slots

as shown in Fig. 11(b). Thus, radiative modes are not excited and coupling losses below 1 dB can be achieved even for cladding heights of 800 nm, see Fig. 11(c) black line. This new geometry is now used for the plasmonic IQ-modulators as discussed further below.

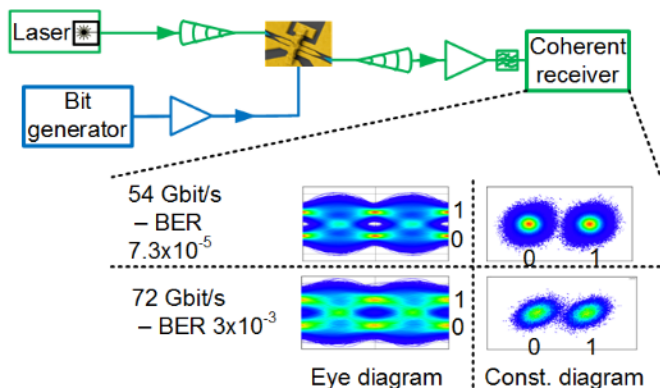
### D. RF-Performance

In order to demonstrate the high speed capabilities of the plasmonic MZM, the electro-optical frequency response of the device was measured. Here, we show record 3 dB bandwidths exceeding 110 GHz for plasmonic modulators, see Fig. 12. In order to measure the frequency range from 75-110 GHz, a special millimeter-wave source and probe were used. Two separate measurements of the same device have been performed. In the first experiment the lower frequency range (15-70GHz) was tested using the same setup as in previous demonstrations [43, 47, 69]. For the higher frequency range, an RF signal was fed into an amplifier combined with a Schottky diode producing multiple harmonics of the input signal. The undesired lower frequency signals were bandpass filtered by the output hollow waveguide. This, way higher harmonic frequencies from 75 to 110GHz were generated. A flat frequency response up to 110 GHz is found and it can be



**Fig. 12 High-speed RF-measurement** Electro-optic frequency response of an all-plasmonic MZM. Two separate measurements were performed for the lower (15-70 GHz) and the higher frequency (75-110 GHz) range. Each measurement was normalized to its starting frequency at 15 GHz and 75 GHz, respectively. No bandwidth limitation can be observed beyond the measurement range of 110 GHz.

expected that the 3dB bandwidth is much higher. Both



**Fig. 13 MZM high-speed data transmission experiment:** Laser light (green) is coupled to and from the chip by grating couplers, amplified and received coherently. The electrical signal (blue) generated by a bit generator is encoded by means of the modulator onto the optical carrier. The received eye diagram and constellation diagrams are shown at the bottom. The bit error ratios (BER) found with this device allow for high-speed data transmission up to 72 GB when utilizing hard decision forward error correction. (Image adapted from Ref. [43].)

measurements are normalized to the value measured at the lowest frequency. In order to estimate the maximum frequency response we can resort to an equivalent circuit analysis. We may assume that the device is RC limited [43]. When neglecting the contact pads and the internal resistivity of the driving source we are left with a device capacitance of 5 fF. Further we have a modulator resistivity of 0.36 Ω indicating a theoretical bandwidth up to 80 THz. In other words, such plasmonic modulators have frequency responses that go way beyond of what is currently needed.

### E. Data Transmission Experiments and Energy Consumption

The all-plasmonic modulator’s capability to encode data at symbol rates up to 72 GBd was demonstrated by performing data generation experiments. Fig. 13 depicts a schematic of the measurement setup and the measured eye and constellation diagrams of the received signal including measured bit-error-ratios (BERs). Light from an external laser ( $\lambda \approx 1534$  nm) was coupled to and from the chip using fully etched grating couplers. The modulated light was amplified before it was

detected by a coherent receiver. In the receiver, standard DSP and post-equalization was applied to mitigate the influence of the limited electrical bandwidth of our RF components. To modulate the light, an electrical data stream (PRBS  $2^{15}-1$ ) was generated by an arbitrary waveform generator (AWG). The electrical signal was amplified and fed to the modulator using GSG RF probes. In a first experiment we investigated the performance at a data rate of 54 Gbit/s using a square-root-raised cosine (SRRC) pulse shape (roll off:  $\alpha = 0.25$ ). The measured BER at 54 Gbit/s was  $7.3 \times 10^{-5}$ . At 72 Gbit/s the BER has increased to  $3 \times 10^{-3}$ , which is still below the HD-FEC limit requiring a 7 % overhead [70].

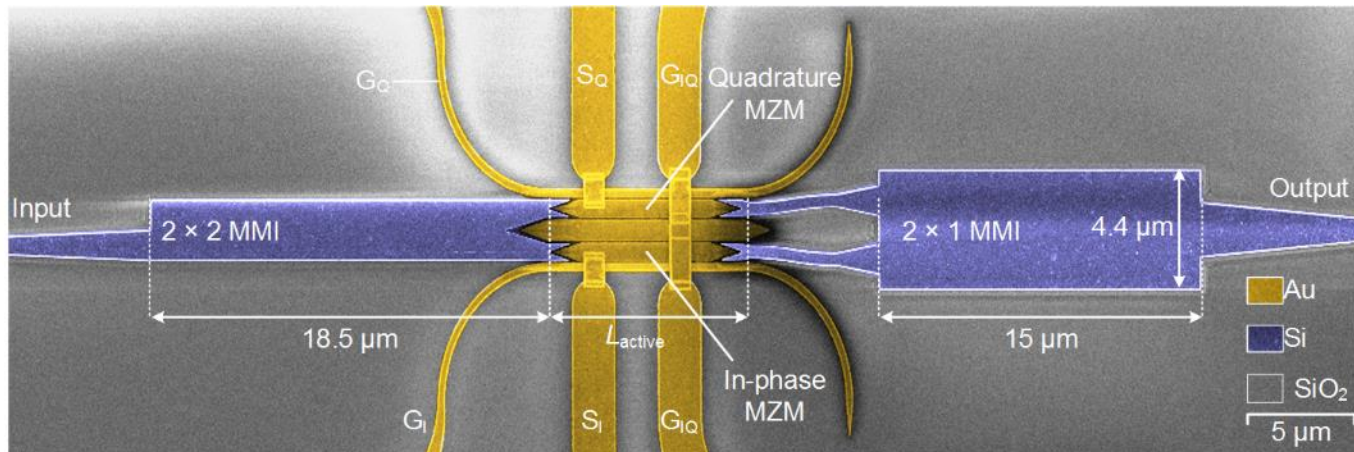
An energy consumption of  $\sim 25$  fJ/bit was derived for a drive voltage of 6 V<sub>pp</sub> and an in-device capacitance of only 2.8 fF [43].

## V. INTEGRATED PLASMONIC IQ-MODULATOR

The above mentioned all-plasmonic MZM is an essential building block for highly-integrated nanophotonic circuits. Besides offering the benefits of a small footprint it also offers seamless integration capabilities with multiple plasmonic devices. As an example for highest integration, we introduce a plasmonic IQ-modulator. We obtain a 1300-fold reduction in area compared to state-of-the art semiconductor IQ modulators [71-73] by merging two plasmonic Mach-Zehnder modulators into an IQ modulator on a footprint of  $10 \mu\text{m} \times 75 \mu\text{m}$  [44]. In the following we introduce the design of the plasmonic IQ modulator together with its operation principle. We then show its performance as well as data transmission beyond 100 Gbit/s.

### A. Device Design and Operation Principle

The plasmonic IQ-modulator consists of two all-plasmonic MZM in the arms of an outer MZM, see Fig. 14. Light from the left silicon single mode waveguide is fed into a  $2 \times 2$  MMI (with only one input waveguide but two output waveguides). The  $2 \times 2$  MMI splits an input carrier equally onto two outputs while introducing a relative phase delay of  $\Delta\phi = \pi/2$  between them. The in-phase (I) and quadrature (Q) components of the carrier are then fed onto two all-plasmonic MZM, which are independently modulated by two electrical signals applied via



**Fig. 14 Colorized SEM image of a plasmonic IQ modulator** comprising two seamlessly integrated MZMs embedded between two MMIs. Light fed from the left input waveguide is equally split by the  $2 \times 2$  MMI and mapped with a  $90^\circ$  offset onto the upper and lower plasmonic MZM. Information is encoded onto the optical carrier by means of the I and Q MZMs, which are connected via suspended bridges with the two electrical data signals ( $S_Q$  and  $S_I$ ). Finally, the two signals form the modulated signal by the subsequent  $2 \times 1$  MMI.



pads  $S_Q$  and  $S_I$ , respectively. Modulated light from the two modulators is then combined by a symmetric  $2 \times 1$  MMI and is coupled to an output silicon single mode waveguide.

The integrated MZMs share a common ground electrode ( $G_{IQ}$ ) acting as an electrical shield, and thus, suppressing electrical crosstalk between in-phase and quadrature component. The signal electrodes ( $S_I$  and  $S_Q$ ) of the two MZMs and the common ground electrode are contacted by suspended bridges. The outer ground electrodes ( $G_I$  and  $G_Q$ ) of the modulators have been implemented as Au strips of 300 nm width.

### B. Device Performance

The RF bandwidth of the IQ modulators has been characterized for up to 70 GHz and found to be flat. We expect them to be flat up to 110 GHz and beyond similar to the MZM, see section IV.D.

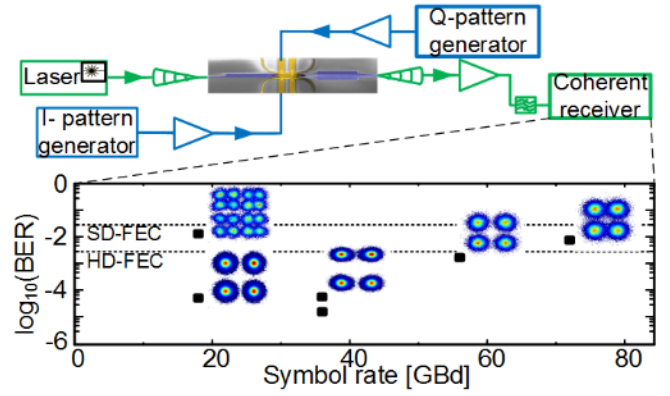
Next, the device has been tested for electrical crosstalk between the in-phase and quadrature-phase MZM. The electrical crosstalk was found to be smaller than -34.5 dB. The measurement was performed by applying a sinusoidal RF signals ( $10 \text{ GHz} \leq f_{RF} \leq 50 \text{ GHz}$ ) to one modulator and measuring the electrical signal on the other modulator using an electrical spectrum analyzer (ESA). The good suppression of crosstalk is probably due to the common ground electrode ( $G_{IQ}$ ) and the small electrode length.

In a next step we investigated the insertion losses of the IQ modulators. They were found to be 13.5 dB. To distinguish contributions of the individual components we used test structures on the same chip. The  $1 \times 2$  MMI contributes with 3.5 dB and the PPIs with 1.5 dB per converter. Another 7 dB are attributed to the  $12 \mu\text{m}$  long and 85 nm wide plasmonic slot waveguides. This corresponds to plasmonic propagation losses of  $0.58 \text{ dB}/\mu\text{m}$ , which are higher than in previous batches and are related to variations in the fabrication process [43, 74]. Based on our previous experiments we expect to be able to reduce propagation losses by 1.8 dB.

### C. Data Experiment

To evaluate the performance of the plasmonic IQ modulator high-speed data transmission experiments were performed. The modulator was used to encode complex modulation formats onto an optical carrier. Encoding a quadrature phase-shift keying (QPSK) signal at a symbol rate of 72 GBd resulted in line rates of 144 Gbit/s. Operation at higher modulation formats like 16-quadrature amplitude modulation (16-QAM) were demonstrated at 18 GBd, see the constellation diagrams in Fig. 15.

The data transmission experiments were performed using an external laser source ( $1535 \text{ nm} \leq \lambda \leq 1550 \text{ nm}$ ). Light was coupled to and from the chip using standard silicon grating couplers. The modulated signal was pre-amplified before it was received by a coherent homodyne detector. The electrical in-phase and quadrature-phase components were generated by two synchronized AWGs and were amplified to  $\pm 2.5 V_p$  as measured at  $50 \Omega$ . The unterminated device gives an advantage of a factor of two, so that we expect a  $\pm 5 V_p$  across the



**Fig. 15 IQ high-speed data transmission experiment:** Laser light (green) is coupled to and from the chip by means of grating couplers, amplified and received coherently. The in- and quadrature phase components of the IQ modulator are encoded by electrical waveform generators (blue). The black squares indicate the received bit-error-ratios (BER) at some specific symbol rates. The corresponding constellation diagrams are plotted next to the squares. BER are below HD-FEC for symbol rates up to 54 GBd and below SD-FEC for QPSK at 72 GBd and 16-QAM 18 GBd resulting in line rates of 144 Gbit/s.

modulators [47]. The electrical signals were applied using two electrical GSG RF probes. To adjust the operating points of the modulators a DC bias of up to  $\pm 6 \text{ V}$  was applied.

The devices were tested for modulation performance at symbol rates from 18 GBd to 56 GBd using a SRRC pulse shape (roll off:  $\alpha = 1$  to 0.28) and at 72 GBd using a rectangular pulse shape with a  $2^{11}$  bit long De Bruijn sequences. In all experiments standard DSP, pre-distortion and post-equalization was applied to compensate for the limited performance of the electrical components.

To verify the device performance in the high-speed data transmission experiments we measured the BER of the received signals. Fig. 15 visualizes the measured BERs for different symbol rates and modulation formats. To show the signal quality the corresponding constellation diagrams are inserted next to the data points. The devices C and D were used for the QPSK experiments while the device E was used for the 16 QAM experiments, Table 1. For signals up to 56 GBd QPSK corresponding to a line rate of 112 Gbit/s, the error ratios are well below the HD-FEC limit (7 % overhead) of  $2 \times 10^{-3}$  [70]. At 72 GBd QPSK and 18 GBd 16QAM the measured BERs are  $7.5 \times 10^{-3}$  and  $1.3 \times 10^{-2}$ , respectively, and are below the SD FEC limit of  $2 \times 10^{-2}$  considering an overhead of 20 % [75].

### D. Energy Consumption

The plasmonic IQ modulator features an energy consumption of 27 fJ/bit with the 16 QAM modulation format. This low energy consumption is a result of the high nonlinear interaction in the plasmonic slot, see Section II. The large nonlinear interaction results in reasonable drive voltages and very short devices. As a result of the short length the device capacitances are small leading to a low energy consumption.

In this section, we investigate the energy consumption of the plasmonic IQ modulator for  $M$ -QAM modulation formats, i.e. QPSK and 16-QAM in the case of an unterminated device [76]. Advanced modulation formats encode  $\log_2(M)$  bits per symbols. Using the probability of a modulation format to switch



from one state (amplitude level) to another, we derive a general expression for the energy consumption per bit of our IQ-modulator when encoding an  $M$ -QAM modulation format.

First, we notice that the IQ-modulator is driven independently by two MZMs, so that the total energy consumption per bit is obtained as a sum of the two modulators' switching energy

$$W_{IQ} = W_{I,MZM} + W_{Q,MZM} \quad (14)$$

Thus, in the case of symmetric operation where both individual MZMs are driven with an identical voltage, we can reduce the discussion to the energy consumption of only one modulator.

Second, we operate the all-plasmonic MZMs unterminated (capacitive) so that hardly any current is flowing across the NLO material which is acting as an insulator. Thus, the dissipated switching energy for changing the voltage ( $U_{pp}$ ) of the MZM's capacitor ( $C_{MZM}$ ) is given by [77]

$$W_{switch,MZM} = \frac{1}{2} U_{switch}^2 C_{MZM}. \quad (15)$$

In general, both I and Q signals have each  $M_{PAM} = \text{sqrt}(M)$  states. These states are equally separated by voltage steps of  $U_{pp}/(\text{sqrt}(M)-1)$ , where  $U_{pp}$  is the peak to peak voltage of the signal. The probability to be in a certain state A and to switch to another state B is equally distributed and given by

$$P_{A \rightarrow B} = \frac{1}{(\log_2(M))^2}. \quad (16)$$

Based on this we can derive the total energy consumption for a transition from any symbol A to any symbol B by

$$W_{MZM,Symbol} = \sum_{A \in n} \sum_{B \in n} \frac{1}{P_{A \rightarrow B}} \cdot \frac{(U_A - U_B)^2 C_{MZM}}{2}. \quad (17)$$

Furthermore, one transmitted symbol contains  $\log_2(M)$  bits leading to the following energy consumption per bit for an IQ modulator

$$W_{IQ,bit} = 2 \cdot W_{MZM} = 2 \cdot \frac{\sum_{A \in n} \sum_{B \in n} \frac{1}{P_{A \rightarrow B}} \cdot \frac{(U_A - U_B)^2 C_{MZM}}{2}}{\log_2(M)}. \quad (18)$$

For the QPSK or 4-QAM modulation format the energy per bit is given by

$$W_{IQ,4-QAM,bit} = \frac{1}{4} U_{pp-signal}^2 C_{MZM}. \quad (19)$$

and

$$W_{IQ,16-QAM,bit} = \frac{5}{72} U_{pp-signal}^2 C_{MZM} \quad (20)$$

In order to estimate the energy consumption per bit of the IQ modulator, the  $C_{MZM}$  capacitance was determined relying on 3D FEM simulations (CST Microwave Studio) using the geometries as found from SEM pictures of the fabricated devices (C-E). With this we can then derive capacitances of

7.67 fF for the device that performed QPSK operation and 4 fF for the device that performed 16-QAM operation.

Applying this formula we can derive an energy consumption of 143 fJ/bit for the QPSK modulation format and a very low value of 27fJ/bit for the 16-QAM modulator when the driving voltage is  $U_p = 5$  V as in our experiment.

### E. Summary

The plasmonic organic hybrid technology is evolving quickly. It has become a viable solution for active photonics - offering exceptionally compact devices with dimensions in the  $\mu\text{m}$ -range, operation across a large optical spectrum of  $>100$  nm and a large electro-optical bandwidth way beyond 100 GHz. In this review we have shown the progress from initial phase-shifters to more complex IQ modulators that meanwhile feature extinction ratios of  $>20$  dB, voltage-length products of only 40  $\text{V}\mu\text{m}$ , and operation at line rates of 144 Gbit/s.

Plasmonics has shown to be a viable technology not only for simple modulators but also for the most complex modulators such as IQ-modulators. Based on this success, future large scale implementation of plasmonics in PICs seems to become practical. To put the scaling potential in a larger context one should keep in mind that 1000 of the new plasmonic IQ modulators introduced here could be arranged on 1  $\text{mm}^2$  surface. As each of them is capable of generating 100 Gbit/s, the on-chip data rate generation capability can easily exceed 100 Tbit/ $\text{mm}^2$ .

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## VII. APPENDIX - METHODS.

### A. Simulations

Simulations were conducted partially by using the commercial Multiphysics FEM tool COMSOL and by using the commercial FDTD solver LUMERICAL. LUMERICAL was used to determine the PPIs' coupling efficiency (Fig. 11) with help of full-wave 3D simulations. COMSOL was used to solve for electrical and optical field profiles (Fig. 2, Fig. 5) from which we derive the light-matter interaction (Fig. 6 Fig. 7) and the achievable extinction ratio Fig. 9. Throughout the simulations we assumed a wavelength of  $1.55\mu\text{m}$  and the corresponding optical properties of the materials at this wavelength:  $n_{\text{NLO}} = 1.83$ ,  $n_{\text{SiO}_2} = 1.44$ ,  $n_{\text{Si}} = 3.5$ ,  $n_{\text{SiO}_2} = 1.44$  and  $\epsilon_{\text{Au}} = -108.9 + 5.27j$ . The Si waveguide has a height of 220 nm and a width of 450 nm. The taper angle of the Au and Si tip is  $15^\circ$ . The capacitance used to estimate the energy consumption of the

plasmonic modulators was obtained from full-wave 3D FEM simulations with CST Microwave Studio.

**B. Fabrication**

The devices were fabricated on a silicon-on-insulator substrate with a 220 nm high silicon device layer on top of a 3 μm thick SiO<sub>2</sub> buried oxide layer. Electron-beam lithography and dry etching were used to define silicon grating couplers, multimode interference couplers and silicon feeding waveguides. Contact electrodes and plasmonic slot waveguides were fabricated by electron beam lithography and a lift-off process applied to e-beam evaporated gold. The suspended bridges were realized with gold using a sacrificial layer. The nonlinear optical material DLD164 [61] was applied by spin-coating and was poled at elevated temperatures near the glass transition temperature of the material.

**C. Fabricated Devices**

This review contains results obtained from various all-plasmonic Mach-Zehnder modulators and plasmonic IQ modulators. For a better overview a summary of the various reported modulators’ parameters is given in the following

*Table 1 Device parameters of the various modulators reported in this review*

DEVICE [REF.]	w <sub>1</sub> [nm]	w <sub>2</sub> [nm]	l [μm]	h <sub>Au</sub> [nm]	TYPE
A[43]	90	100	5	200	MZM
B	40	45	6	150	MZM
C [44]	35	40	12	150	IQ
D [44]	80	90	8	150	IQ
E [44]	80	90	12	150	IQ

w<sub>1</sub> and w<sub>2</sub> are the width of the Mach-Zehnder’s phase shifters while l is the length of the phase shifter. h is the height of the deposited Au. In the case of the IQ modulators the two MZMs are equal.

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